

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10551817	LIN ET AL..
Examiner	Art Unit	
Cheng, Ichieh	4183	

SEARCHED

Class	Subclass	Date	Examiner
455	452.1-452.2	7/29/2008	SR
370	310.1,331,338	7/29/2008	SR

SEARCH NOTES

Search Notes	Date	Examiner
EAST	7/29/2008	SR

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner